

Notice of References Cited		Application/Control No. 10/580,832	Applicant(s)/Patent Under Reexamination SUH ET AL.	
		Examiner JENNIFER DOAN	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,357,510 B2	04-2008	Kim et al.	353/7
*	B	US-6,513,953 B1	02-2003	Itoh, Yoshitaka	362/331
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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